

DRV8300: 100-V Three-Phase BLDC Gate Driver

1 Features

- 100-V Three Phase Half-Bridge Gate driver
 - Drives N-Channel MOSFETs (NMOS)
 - Gate Driver Supply (GVDD): 5-20V
 - MOSFET supply (SHx) support upto 100V
- Integrated Bootstrap Diodes (DRV8300D devices)
- Supports Inverting and Non-Inverting INLx inputs
- Bootstrap gate drive architecture
 - 750-mA source current
 - 1.5-A sink current
- Supports upto 15s battery powered applications
- Low leakage current on SHx pins (<55 μ A)
- Absolute maximum BSTx voltage upto 115-V
- Supports negative transients upto -22-V on SHx
- Built-in cross conduction prevention
- Adjustable deadtime through DT pin for QFN package variants
- Fixed deadtime insertion of 200 nS for TSSOP package variants
- Supports 3.3-V and 5-V logic inputs with 20V Abs max
- 4 nS typical propagation delay matching
- Compact QFN and TSSOP packages
- Efficient system design with [Power Blocks](#)
- Integrated protection features
 - BST undervoltage lockout (BSTUV)
 - GVDD undervoltage (GVDDUV)

2 Applications

- E-Bikes, E-Scooters, and E-Mobility
- Fans, Pumps, and Servo Drives
- Brushless-DC (BLDC) Motor Modules and PMSM
- Cordless Garden and Power Tools, Lawnmowers
- Cordless Vacuum Cleaners
- Drones, Robotics, and RC Toys
- Industrial and Logistics Robots

3 Description

DRV8300 is 100-V three half-bridge gate drivers, capable of driving high-side and low-side N-channel power MOSFETs. The DRV8300D generates the correct gate drive voltages using an integrated bootstrap diode and external capacitor for the high-side MOSFETs. The DRV8300N generates the correct gate drive voltages using an external bootstrap diode and external capacitor for the high-side MOSFETs. GVDD is used to generate gate drive voltage for the low-side MOSFETs. The Gate Drive architecture

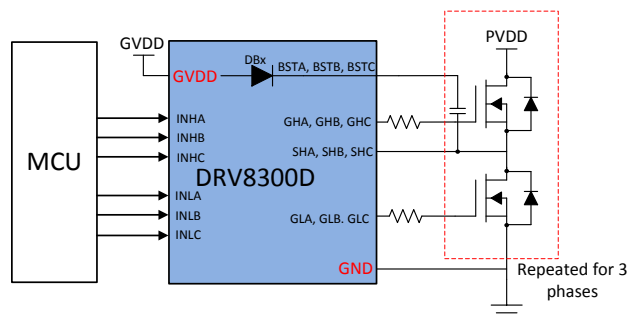
supports peak up to 750-mA source and 1.5-A sink currents.

The phase pins SHx is able to tolerate the significant negative voltage transients; while high side gate driver supply BSTx and GHx is able to support to higher positive voltage transients (115-V) abs max voltage which improves robustness of the system. Small propagation delay and delay matching specifications minimize the dead-time requirement which further improves efficiency. Undervoltage protection is provided for both low and high side through GVDD and BST undervoltage lockout.

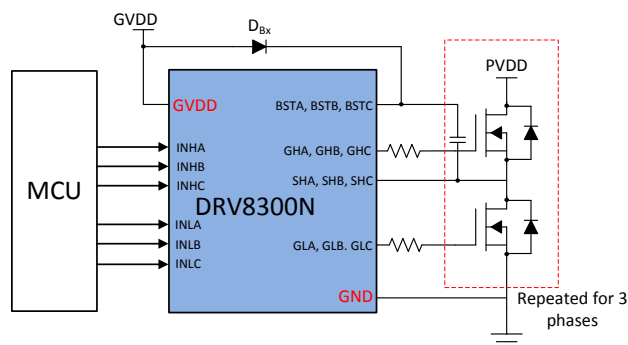
Device Information (1)

| PART NUMBER | PACKAGE | BODY SIZE (NOM) |
|-------------|------------|-------------------|
| DRV8300DIPW | TSSOP (20) | 6.40 mm × 4.40 mm |
| DRV8300DPW | TSSOP (20) | 6.40 mm × 4.40 mm |
| DRV8300NIPW | TSSOP (20) | 6.40 mm × 4.40 mm |
| DRV8300NPW | TSSOP (20) | 6.40 mm × 4.40 mm |
| DRV8300DRGE | VQFN (24) | 4.00 mm × 4.00 mm |
| DRV8300NRGE | VQFN (24) | 4.00 mm × 4.00 mm |

- (1) For all available packages, see the orderable addendum at the end of the data sheet.



Simplified Schematic for DRV8300D



Simplified Schematic for DRV8300N



Table of Contents

| | | | |
|--|-----------|--|-----------|
| 1 Features | 1 | 8.3 Feature Description..... | 14 |
| 2 Applications | 1 | 8.4 Device Functional Modes..... | 16 |
| 3 Description | 1 | 9 Application and Implementation | 17 |
| 4 Revision History | 2 | 9.1 Application Information..... | 17 |
| 5 Device Comparison Table | 3 | 9.2 Typical Application..... | 18 |
| 6 Pin Configuration and Functions | 4 | 10 Power Supply Recommendations | 21 |
| 7 Specifications | 6 | 11 Layout | 22 |
| 7.1 Absolute Maximum Ratings | 6 | 11.1 Layout Guidelines..... | 22 |
| 7.2 ESD Ratings Comm | 6 | 11.2 Layout Example..... | 22 |
| 7.3 Recommended Operating Conditions | 6 | 12 Device and Documentation Support | 23 |
| 7.4 Thermal Information | 7 | 12.1 Receiving Notification of Documentation Updates..... | 23 |
| 7.5 Electrical Characteristics | 7 | 12.2 Support Resources..... | 23 |
| 7.6 Timing Diagrams..... | 9 | 12.3 Trademarks..... | 23 |
| 7.7 Typical Characteristics..... | 10 | 12.4 Electrostatic Discharge Caution..... | 23 |
| 8 Detailed Description | 11 | 12.5 Glossary..... | 23 |
| 8.1 Overview..... | 11 | 13 Mechanical, Packaging, and Orderable Information | 23 |
| 8.2 Functional Block Diagram..... | 12 | | |

4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

| | |
|--|-------------|
| Changes from Revision B (February 2021) to Revision C (February 2021) | Page |
| • Removed "Preview" status from RGE devices..... | 1 |

| | |
|--|-------------|
| Changes from Revision A (December 2020) to Revision B (February 2021) | Page |
| • Removed "Preview" status from PW devices..... | 1 |

| | |
|---|-------------|
| Changes from Revision * (September 2020) to Revision A (December 2020) | Page |
| • Updated device status to Production Data..... | 1 |

5 Device Comparison Table

| Device Variants | Package | Integrated Bootstrap Diode | GLx polarity with respect to INLx Input | Deadtime |
|-----------------|--------------|----------------------------|---|----------|
| DRV8300DI | 20-Pin TSSOP | Yes | Inverted | Fixed |
| DRV8300D | | Yes | Non-Inverted | Fixed |
| DRV8300N | | No | Non-Inverted | Fixed |
| DRV8300NI | | No | Inverted | Fixed |
| DRV8300N | 24-Pin VQFN | No | Non-Inverted or Inverted | Variable |
| DRV8300D | | Yes | Non-Inverted or Inverted | Variable |

6 Pin Configuration and Functions

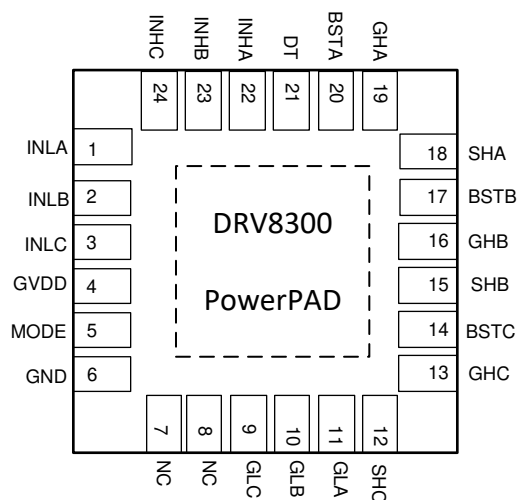


Figure 6-1. DRV8300D, DRV8300N RGE Package 24-Pin VQFN With Exposed Thermal Pad Top View

Table 6-1. Pin Functions—24-Pin DRV8300 Devices

| PIN | | TYPE ⁽¹⁾ | DESCRIPTION |
|------|------|---------------------|--|
| NAME | NO. | | |
| BSTA | 20 | O | Bootstrap output pin. Connect capacitor between BSTA and SHA |
| BSTB | 17 | O | Bootstrap output pin. Connect capacitor between BSTB and SHB |
| BSTC | 14 | O | Bootstrap output pin. Connect capacitor between BSTC and SHC |
| DT | 21 | I | Deadtime input pin. Connect resistor to ground for variable deadtime, fixed deadtime when left it floating |
| GHA | 19 | O | High-side gate driver output. Connect to the gate of the high-side power MOSFET. |
| GHB | 16 | O | High-side gate driver output. Connect to the gate of the high-side power MOSFET. |
| GHC | 13 | O | High-side gate driver output. Connect to the gate of the high-side power MOSFET. |
| GLA | 11 | O | Low-side gate driver output. Connect to the gate of the low-side power MOSFET. |
| GLB | 10 | O | Low-side gate driver output. Connect to the gate of the low-side power MOSFET. |
| GLC | 9 | O | Low-side gate driver output. Connect to the gate of the low-side power MOSFET. |
| INHA | 22 | I | High-side gate driver control input. This pin controls the output of the high-side gate driver. |
| INHB | 23 | I | High-side gate driver control input. This pin controls the output of the high-side gate driver. |
| INHC | 24 | I | High-side gate driver control input. This pin controls the output of the high-side gate driver. |
| INLA | 1 | I | Low-side gate driver control input. This pin controls the output of the low-side gate driver. |
| INLB | 2 | I | Low-side gate driver control input. This pin controls the output of the low-side gate driver. |
| INLC | 3 | I | Low-side gate driver control input. This pin controls the output of the low-side gate driver. |
| MODE | 5 | I | Mode Input controls polarity of GLx compared to INLx inputs. Mode pin floating: GLx output polarity same(Non-Inverted) as INLx input Mode pin to GVDD: GLx output polarity inverted compared to INLx input |
| NC | 7, 8 | NC | No internal connection. This pin can be left floating or connected to system ground. |
| GND | 6 | PWR | Device ground. |
| SHA | 18 | I | High-side source sense input. Connect to the high-side power MOSFET source. |
| SHB | 15 | I | High-side source sense input. Connect to the high-side power MOSFET source. |
| SHC | 12 | I | High-side source sense input. Connect to the high-side power MOSFET source. |
| GVDD | 4 | PWR | Gate driver power supply input. Connect a X5R or X7R, GVDD-rated ceramic and greater then or equal to 10-uF local capacitance between the GVDD and GND pins. |

(1) PWR = power, I = input, O = output, NC = no connection

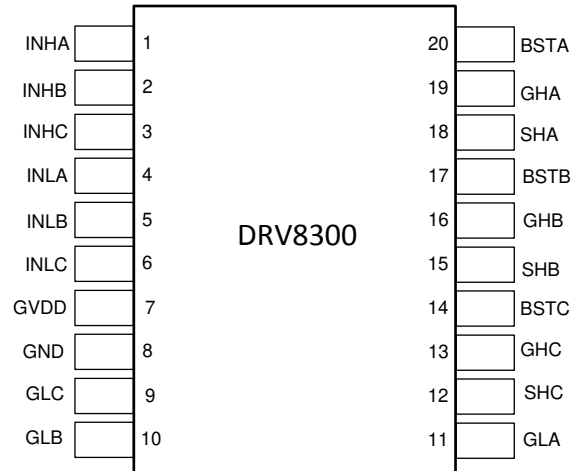


Figure 6-2. DRV8300D, DRV8300N, DRV8300DI, DRV8300NI PW Package 20-Pin TSSOP Top View

Table 6-2. Pin Functions—20-Pin DRV8300 Devices

| PIN | | TYPE ¹ | DESCRIPTION |
|------|-----|-------------------|--|
| NAME | NO. | | |
| BSTA | 20 | O | Bootstrap output pin. Connect capacitor between BSTA and SHA |
| BSTB | 17 | O | Bootstrap output pin. Connect capacitor between BSTB and SHB |
| BSTC | 14 | O | Bootstrap output pin. Connect capacitor between BSTC and SHC |
| GHA | 19 | O | High-side gate driver output. Connect to the gate of the high-side power MOSFET. |
| GHB | 16 | O | High-side gate driver output. Connect to the gate of the high-side power MOSFET. |
| GHC | 13 | O | High-side gate driver output. Connect to the gate of the high-side power MOSFET. |
| GLA | 11 | O | Low-side gate driver output. Connect to the gate of the low-side power MOSFET. |
| GLB | 10 | O | Low-side gate driver output. Connect to the gate of the low-side power MOSFET. |
| GLC | 9 | O | Low-side gate driver output. Connect to the gate of the low-side power MOSFET. |
| INHA | 1 | I | High-side gate driver control input. This pin controls the output of the high-side gate driver. |
| INHB | 2 | I | High-side gate driver control input. This pin controls the output of the high-side gate driver. |
| INHC | 3 | I | High-side gate driver control input. This pin controls the output of the high-side gate driver. |
| INLA | 4 | I | Low-side gate driver control input. This pin controls the output of the low-side gate driver. |
| INLB | 5 | I | Low-side gate driver control input. This pin controls the output of the low-side gate driver. |
| INLC | 6 | I | Low-side gate driver control input. This pin controls the output of the low-side gate driver. |
| GND | 8 | PWR | Device ground. |
| SHA | 18 | I | High-side source sense input. Connect to the high-side power MOSFET source. |
| SHB | 15 | I | High-side source sense input. Connect to the high-side power MOSFET source. |
| SHC | 12 | I | High-side source sense input. Connect to the high-side power MOSFET source. |
| GVDD | 7 | PWR | Gate driver power supply input. Connect a X5R or X7R, GVDD-rated ceramic and greater than or equal to 10-μF local capacitance between the GVDD and GND pins. |

1. PWR = power, I = input, O = output, NC = no connection

7 Specifications

7.1 Absolute Maximum Ratings

over operating temperature range (unless otherwise noted)⁽¹⁾

| | | MIN | MAX | UNIT |
|---|--------------------------|------|------------------------|------|
| Gate driver regulator pin voltage | GVDD | -0.3 | 21.5 | V |
| Bootstrap pin voltage | BSTx | -0.3 | 115 | V |
| Bootstrap pin voltage | BSTx with respect to SHx | -0.3 | 21.5 | V |
| Logic pin voltage | INHx, INLx, MODE, DT | -0.3 | V _{GVDD} +0.3 | V |
| High-side gate drive pin voltage | GHx | -22 | 115 | V |
| High-side gate drive pin voltage | GHx with respect to SHx | -0.3 | 22 | V |
| Transient 500-ns high-side gate drive pin voltage | GHx with respect to SHx | -5 | 22 | V |
| Low-side gate drive pin voltage | GLx | -0.3 | V _{GVDD} +0.3 | V |
| Transient 500-ns low-side gate drive pin voltage | GLx | -5 | V _{GVDD} +0.3 | V |
| High-side source pin voltage | SHx | -22 | 100 | V |
| Ambient temperature, T _A | | -40 | 125 | °C |
| Junction temperature, T _J | | -40 | 150 | °C |
| Storage temperature, T _{stg} | | -65 | 150 | °C |

- (1) Stresses beyond those listed under *Absolute Maximum Rating* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Condition*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

7.2 ESD Ratings Comm

| | | VALUE | UNIT |
|--------------------|-------------------------|--|-------|
| V _(ESD) | Electrostatic discharge | Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾ | ±1000 |
| | | Charged device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾ | ±250 |

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
 (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

7.3 Recommended Operating Conditions

over operating temperature range (unless otherwise noted)

| | | | MIN | NOM | MAX | UNIT |
|----------------------------------|---|--------------------------|-----|-----|------|------|
| V _{GVDD} | Power supply voltage | GVDD | 5 | | 20 | V |
| V _{SHx} | High-side source pin voltage | SHx | -2 | | 85 | V |
| V _{SHx} | Transient 2μs high-side source pin voltage | SHx | -22 | | 85 | V |
| V _{BST} | Bootstrap pin voltage | BSTx | 5 | | 105 | V |
| V _{BST} | Bootstrap pin voltage | BSTx with respect to SHx | 5 | | 20 | V |
| V _{IN} | Logic input voltage | INHx, INLx, MODE, DT | 0 | | GVDD | V |
| f _{PWM} | PWM frequency | INHx, INLx | 0 | | 200 | kHz |
| V _{SHSL} | Slew rate on SHx pin (DRV8300D and DRV8300DI) | | | | 2 | V/ns |
| V _{SHSL} | Slew rate on SHx pin (DRV8300N and DRV8300NI) | | | | 50 | V/ns |
| C _{BOOT} ⁽¹⁾ | Capacitor between BSTx and SHx (DRV8300D and DRV8300DI) | | | | 1 | μF |
| T _A | Operating ambient temperature | | -40 | | 125 | °C |

over operating temperature range (unless otherwise noted)

| | | MIN | NOM | MAX | UNIT |
|----------------|--------------------------------|-----|-----|-----|------|
| T _J | Operating junction temperature | –40 | | 150 | °C |

- (1) Current flowing through boot diode (D_{BOOT}) needs to be limited for C_{BOOT} > 1μF

7.4 Thermal Information

| THERMAL METRIC ⁽¹⁾ | | DRV8300 | | UNIT |
|-------------------------------|--|------------|------------|------|
| | | PW (TSSOP) | RGE (VQFN) | |
| | | 20 PINS | 24 PINS | |
| R _{θJA} | Junction-to-ambient thermal resistance | 97.4 | 49.3 | °C/W |
| R _{θJC(top)} | Junction-to-case (top) thermal resistance | 38.3 | 42.5 | °C/W |
| R _{θJB} | Junction-to-board thermal resistance | 48.8 | 26.5 | °C/W |
| Ψ _{JT} | Junction-to-top characterization parameter | 4.3 | 2.2 | °C/W |
| Ψ _{JB} | Junction-to-board characterization parameter | 48.4 | 26.4 | °C/W |
| R _{θJC(bot)} | Junction-to-case (bottom) thermal resistance | N/A | 11.5 | °C/W |

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

7.5 Electrical Characteristics

4.8 V ≤ V_{GVDD} ≤ 20 V, –40°C ≤ T_J ≤ 150°C (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--|---|---|------|------|------|------|
| POWER SUPPLIES (GVDD, BSTx) | | | | | | |
| I _{GVDD} | GVDD standby mode current | INHx = INLx = 0; V _{BSTx} = V _{GVDD} | 400 | 800 | 1400 | μA |
| | GVDD active mode current | INHx = INLx = Switching @20kHz; V _{BSTx} = V _{GVDD} ; NO FETs connected | 400 | 825 | 1400 | μA |
| IL _{BSx} | Bootstrap pin leakage current | V _{BSTx} = V _{SHx} = 85V; V _{GVDD} = 0V | 2 | 4 | 7 | μA |
| IL _{BS_TRAN} | Bootstrap pin active mode transient leakage current | INHx = Switching@20kHz | 30 | 105 | 220 | μA |
| IL _{BS_DC} | Bootstrap pin active mode leakage static current | INHx = High | 30 | 85 | 150 | μA |
| IL _{SHx} | High-side source pin leakage current | INHx = INLx = 0; V _{BSTx} - V _{SHx} = 12V; V _{SHx} = 0 to 85V | 30 | 55 | 80 | μA |
| LOGIC-LEVEL INPUTS (INHx, INLx, MODE) | | | | | | |
| V _{IL_MODE} | Input logic low voltage | Mode pin | | | 0.6 | V |
| V _{IL} | Input logic low voltage | INLx, INHx pins | | | 0.8 | V |
| V _{IH_MODE} | Input logic high voltage | Mode pin | 3.7 | | | V |
| V _{IH} | Input logic high voltage | INLx, INHx pins | 2.0 | | | V |
| V _{HYS_MODE} | Input hysteresis | Mode pin | 1600 | 2000 | 2400 | mV |
| V _{HYS} | Input hysteresis | INLx, INHx pins | 40 | 100 | 260 | mV |
| I _{IL_INLx} | INLx Input logic low current | V _{PIN} (Pin Voltage) = 0 V; INLx in non-inverting mode | –1 | 0 | 1 | μA |
| | | V _{PIN} (Pin Voltage) = 0 V; INLx in inverting mode | 5 | 20 | 30 | μA |
| I _{IH_INLx} | INLx Input logic high current | V _{PIN} (Pin Voltage) = 5 V; INLx in non-inverting mode | 5 | 20 | 30 | μA |
| | | V _{PIN} (Pin Voltage) = 5 V; INLx in inverting mode | 0 | 0.5 | 1.5 | μA |
| I _{IL} | INHx, MODE Input logic low current | V _{PIN} (Pin Voltage) = 0 V; | –1 | 0 | 1 | μA |
| I _{IH} | INHx, MODE Input logic high current | V _{PIN} (Pin Voltage) = 5 V; | 5 | 20 | 30 | μA |

DRV8300

SLVSFG5C – SEPTEMBER 2020 – REVISED FEBRUARY 2021

 $4.8\text{ V} \leq V_{\text{GVDD}} \leq 20\text{ V}$, $-40^{\circ}\text{C} \leq T_{\text{J}} \leq 150^{\circ}\text{C}$ (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|--|------|---------|------|------------|
| $R_{\text{PD_INHx}}$ | INHx Input pulldown resistance | To GND | 120 | 200 | 280 | k Ω |
| $R_{\text{PD_INLx}}$ | INLx Input pulldown resistance | To GND, INLx in non-inverting mode | 120 | 200 | 280 | k Ω |
| $R_{\text{PU_INLx}}$ | INLx Input pullup resistance | To INT_5V, INLx in inverting mode | 120 | 200 | 280 | k Ω |
| $R_{\text{PD_MODE}}$ | MODE Input pulldown resistance | To GND | 120 | 200 | 280 | k Ω |
| GATE DRIVERS (GHx, GLx, SHx, SLx) | | | | | | |
| $V_{\text{GHx_LO}}$ | High-side gate drive low level voltage | $I_{\text{GLx}} = -100\text{ mA}$; $V_{\text{GVDD}} = 12\text{ V}$; No FETs connected | 0 | 0.15 | 0.35 | V |
| $V_{\text{GHx_HI}}$ | High-side gate drive high level voltage ($V_{\text{BSTx}} - V_{\text{GHx}}$) | $I_{\text{GHx}} = 100\text{ mA}$; $V_{\text{GVDD}} = 12\text{ V}$; No FETs connected | 0.3 | 0.6 | 1.2 | V |
| $V_{\text{GLx_LO}}$ | Low-side gate drive low level voltage | $I_{\text{GLx}} = -100\text{ mA}$; $V_{\text{GVDD}} = 12\text{ V}$; No FETs connected | 0 | 0.15 | 0.35 | V |
| $V_{\text{GLx_HI}}$ | Low-side gate drive high level voltage ($V_{\text{GVDD}} - V_{\text{GLx}}$) | $I_{\text{GHx}} = 100\text{ mA}$; $V_{\text{GVDD}} = 12\text{ V}$; No FETs connected | 0.3 | 0.6 | 1.2 | V |
| $I_{\text{DRIVEP_HS}}$ | High-side peak source gate current | GHx-SHx = 12V | 400 | 750 | 1200 | mA |
| $I_{\text{DRIVEN_HS}}$ | High-side peak sink gate current | GHx-SHx = 0V | 850 | 1500 | 2100 | mA |
| $I_{\text{DRIVEP_LS}}$ | Low-side peak source gate current | GLx = 12V | 400 | 750 | 1200 | mA |
| $I_{\text{DRIVEN_LS}}$ | Low-side peak sink gate current | GLx = 0V | 850 | 1500 | 2100 | mA |
| t_{PD} | Input to output propagation delay | INHx, INLx to GHx, GLx; $V_{\text{GVDD}} = V_{\text{BSTx}} - V_{\text{SHx}} > 8\text{ V}$; SHx = 0V, No load on GHx and GLx | 70 | 125 | 180 | ns |
| $t_{\text{PD_match}}$ | Matching propagation delay per phase | GHx turning OFF to GLx turning ON, GLx turning OFF to GHx turning ON; $V_{\text{GVDD}} = V_{\text{BSTx}} - V_{\text{SHx}} > 8\text{ V}$; SHx = 0V, No load on GHx and GLx | -30 | ± 4 | 30 | ns |
| $t_{\text{PD_match}}$ | Matching propagation delay phase to phase | GHx/GLx turning ON to GHy/GLy turning ON, GHx/GLx turning OFF to GHy/GLy turning OFF; $V_{\text{GVDD}} = V_{\text{BSTx}} - V_{\text{SHx}} > 8\text{ V}$; SHx = 0V, No load on GHx and GLx | -30 | ± 4 | 30 | ns |
| $t_{\text{R_GLx}}$ | GLx rise time (10% to 90%) | $C_{\text{LOAD}} = 1000\text{ pF}$; $V_{\text{GVDD}} = V_{\text{BSTx}} - V_{\text{SHx}} > 8\text{ V}$; SHx = 0V | 10 | 24 | 50 | ns |
| $t_{\text{R_GHx}}$ | GHx rise time (10% to 90%) | $C_{\text{LOAD}} = 1000\text{ pF}$; $V_{\text{GVDD}} = V_{\text{BSTx}} - V_{\text{SHx}} > 8\text{ V}$; SHx = 0V | 10 | 24 | 50 | ns |
| $t_{\text{F_GLx}}$ | GLx fall time (90% to 10%) | $C_{\text{LOAD}} = 1000\text{ pF}$; $V_{\text{GVDD}} = V_{\text{BSTx}} - V_{\text{SHx}} > 8\text{ V}$; SHx = 0V | 5 | 12 | 30 | ns |
| $t_{\text{F_GHx}}$ | GHx fall time (90% to 10%) | $C_{\text{LOAD}} = 1000\text{ pF}$; $V_{\text{GVDD}} = V_{\text{BSTx}} - V_{\text{SHx}} > 8\text{ V}$; SHx = 0V | 5 | 12 | 30 | ns |
| t_{DEAD} | Gate drive dead time | DT pin floating | 150 | 215 | 280 | ns |
| | | DT pin connected to GND | 150 | 215 | 280 | ns |
| | | 40 k Ω between DT pin and GND | 150 | 200 | 260 | ns |
| | | 400 k Ω between DT pin and GND | 1500 | 2000 | 2600 | ns |
| $t_{\text{PW_MIN}}$ | Minimum input pulse width on INHx, INLx that changes the output on GHx, GLx | | 40 | 70 | 150 | ns |
| BOOTSTRAP DIODES (DRV8300D, DRV8300DI) | | | | | | |
| V_{BOOTD} | Bootstrap diode forward voltage | $I_{\text{BOOT}} = 100\text{ }\mu\text{A}$ | 0.45 | 0.7 | 0.85 | V |
| | | $I_{\text{BOOT}} = 100\text{ mA}$ | 2 | 2.3 | 3.1 | V |
| R_{BOOTD} | Bootstrap dynamic resistance ($\Delta V_{\text{BOOTD}} / \Delta I_{\text{BOOT}}$) | $I_{\text{BOOT}} = 100\text{ mA}$ and 80 mA | 11 | 15 | 25 | Ω |
| PROTECTION CIRCUITS | | | | | | |
| V_{GVDDUV} | Gate Driver Supply undervoltage lockout (GVDDUV) | Supply rising | 4.45 | 4.6 | 4.7 | V |
| | | Supply falling | 4.2 | 4.35 | 4.4 | V |

$4.8\text{ V} \leq V_{\text{GVDD}} \leq 20\text{ V}$, $-40^{\circ}\text{C} \leq T_{\text{J}} \leq 150^{\circ}\text{C}$ (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--------------------------|--|-----------------------------|-----|-----|-----|---------------|
| $V_{\text{GVDDUV_HYS}}$ | Gate Driver Supply UV hysteresis | Rising to falling threshold | 250 | 280 | 310 | mV |
| t_{GVDDUV} | Gate Driver Supply undervoltage deglitch time | | 5 | 10 | 13 | μs |
| V_{BSTUV} | Boot Strap undervoltage lockout ($V_{\text{BSTx}} - V_{\text{SHx}}$) | Supply rising | 3.6 | 4.2 | 4.8 | V |
| | Boot Strap undervoltage lockout ($V_{\text{BSTx}} - V_{\text{SHx}}$) | Supply falling | 3.5 | 4 | 4.5 | V |
| $V_{\text{BSTUV_HYS}}$ | Bootstrap UV hysteresis | Rising to falling threshold | | 200 | | mV |
| t_{BSTUV} | Bootstrap undervoltage deglitch time | | 6 | 10 | 22 | μs |

7.6 Timing Diagrams

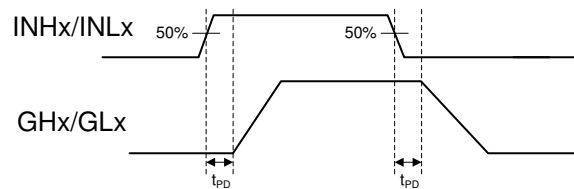


Figure 7-1. Propagation Delay (t_{PD})

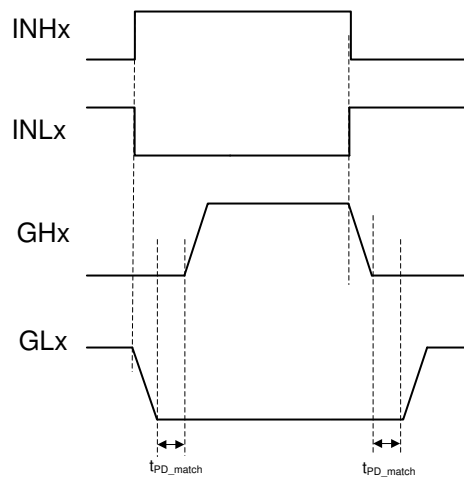


Figure 7-2. Propagation Delay Match ($t_{\text{PD_match}}$)

7.7 Typical Characteristics

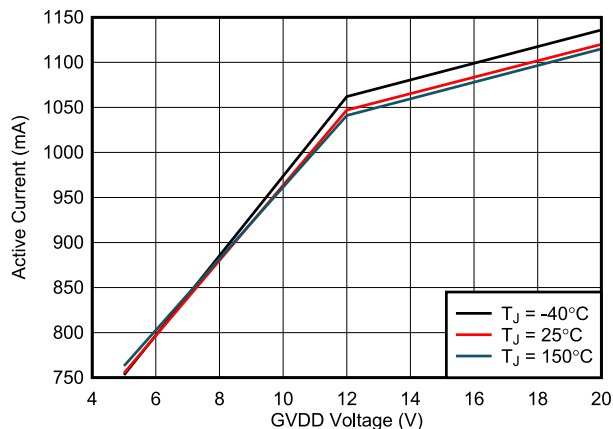


Figure 7-3. Supply Current Over GVDD Voltage

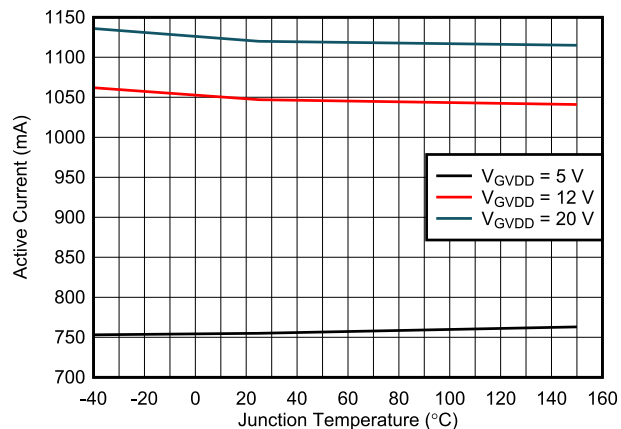


Figure 7-4. Supply Current Over Temperature

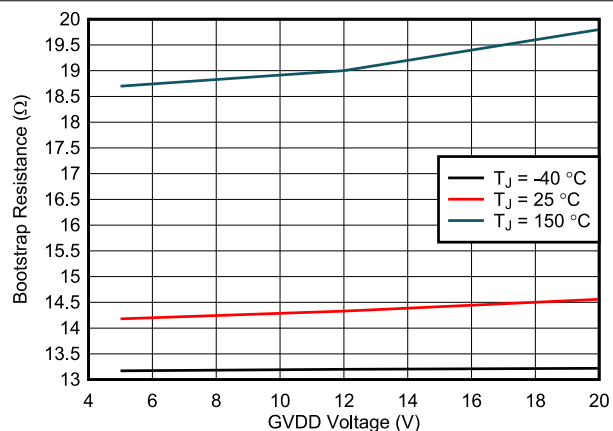


Figure 7-5. Bootstrap Resistance Over GVDD Voltage

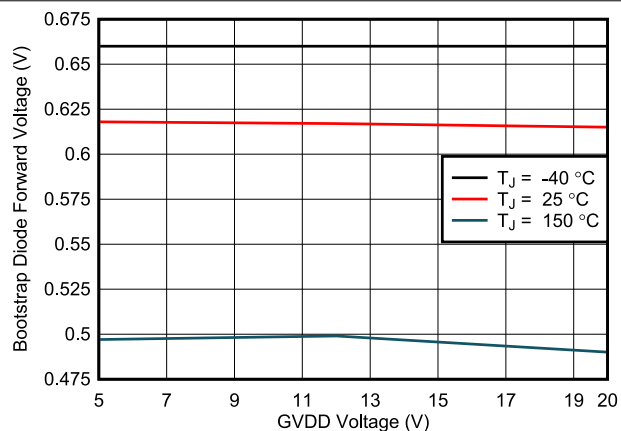


Figure 7-6. Bootstrap Diode Forward Voltage over GVDD Voltage

8 Detailed Description

8.1 Overview

The DRV8300 family of devices is a gate driver for three-phase motor drive applications. These devices decrease system component count, saves PCB space and cost by integrating three independent half-bridge gate drivers and optional bootstrap diodes.

DRV8300 supports external N-channel high-side and low-side power MOSFETs and can drive 750-mA source, 1.5-A sink peak currents with total combined 30-mA average output current. The DRV8300 family of devices are available in 0.5-mm pitch QFN and 0.65-mm pitch TSSOP surface-mount packages. The QFN size is 4 × 4 mm (0.5-mm pin pitch) for the 24-pin package, and TSSOP size is 6.5 × 6.4 mm (0.65-mm pin pitch) for the 20-pin package.

8.2 Functional Block Diagram

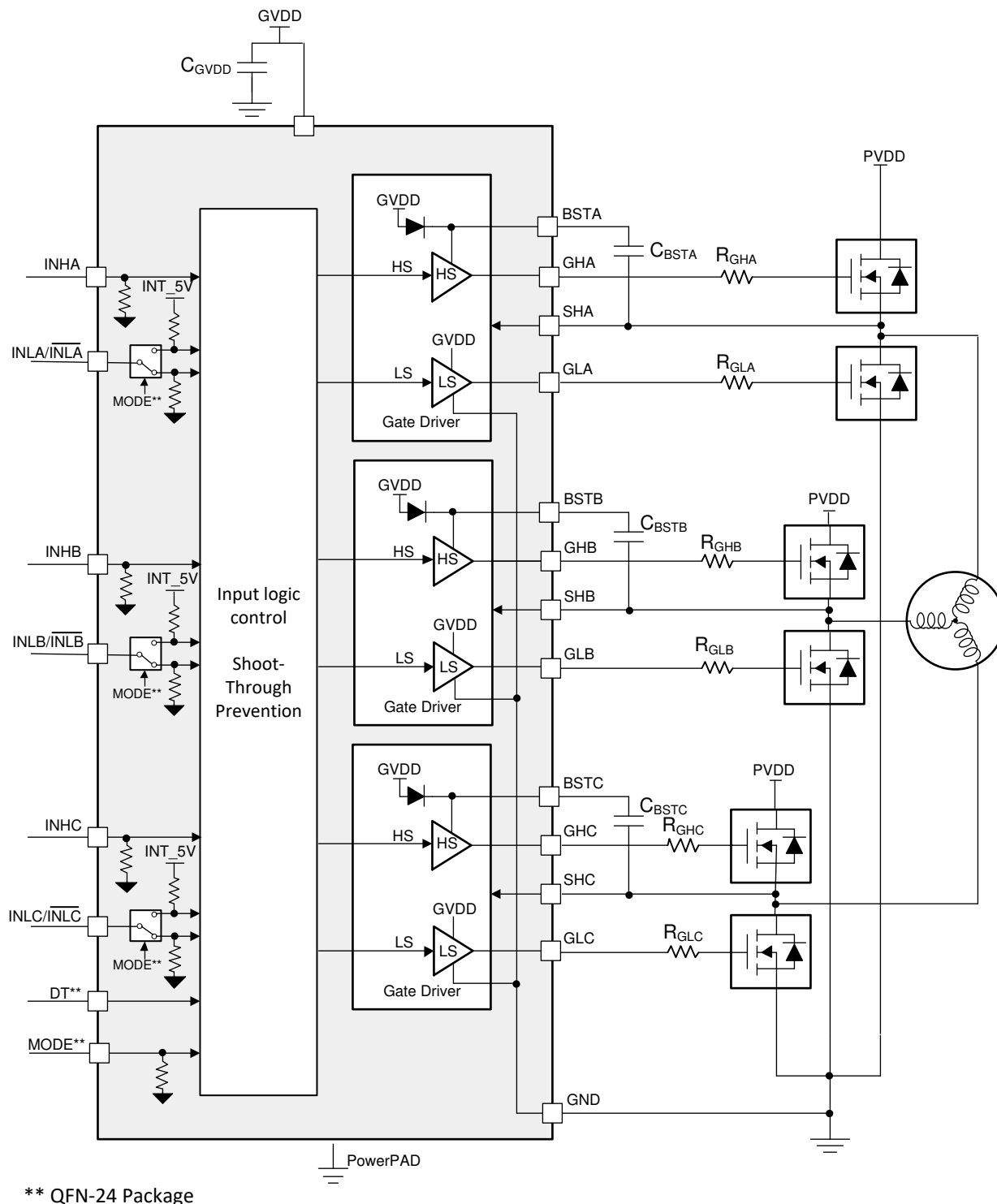
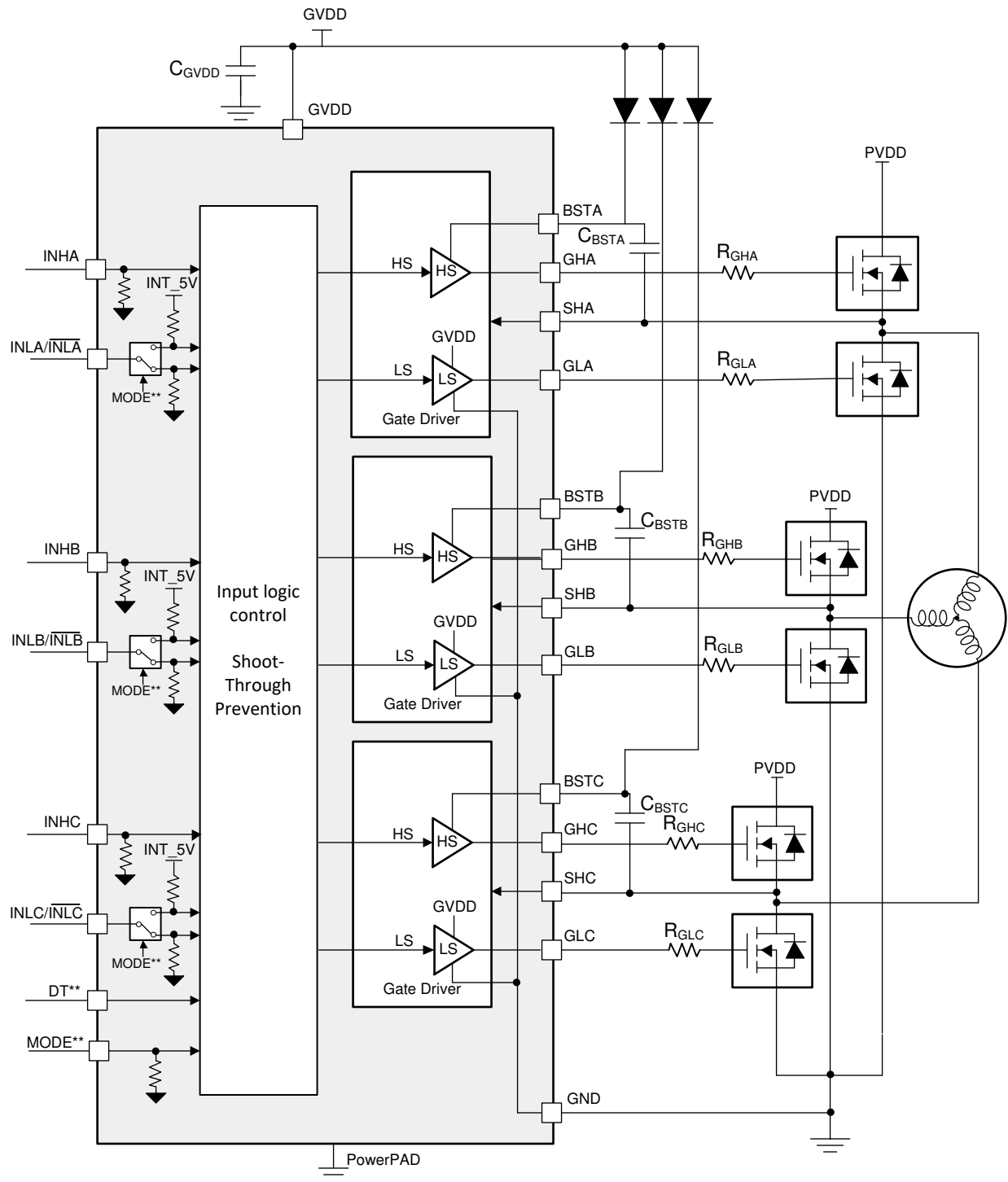


Figure 8-1. Block Diagram for DRV8300D



** QFN-24 Package

Figure 8-2. Block Diagram for DRV8300N

8.3 Feature Description

8.3.1 Three BLDC Gate Drivers

The DRV8300 integrates three half-bridge gate drivers, each capable of driving high-side and low-side N-channel power MOSFETs. Input on GVDD provides the gate bias voltage for the low-side MOSFETs. The high voltage is generated using bootstrap capacitor and GVDD supply. The half-bridge gate drivers can be used in combination to drive a three-phase motor or separately to drive other types of loads.

8.3.1.1 Gate Drive Timings

8.3.1.1.1 Propagation Delay

The propagation delay time (t_{pd}) is measured as the time between an input logic edge to a detected output change. This time has two parts consisting of the input deglitcher delay and the delay through the analog gate drivers.

The input deglitcher prevents high-frequency noise on the input pins from affecting the output state of the gate drivers. The analog gate drivers have a small delay that contributes to the overall propagation delay of the device.

8.3.1.1.2 Deadtime and Cross-Conduction Prevention

In the DRV8300, high- and low-side inputs operate independently, with an exception to prevent cross conduction when high and low side are turned ON at same time. The DRV8300 turns OFF high- and low- side output to prevent shoot through when high- and low-side inputs are logic high at same time.

The DRV8300 also provides deadtime insertion to prevents both external MOSFETs of each power-stage from switching on at the same time. In devices with DT pin (QFN package device), deadtime can be linearly adjusted between 200 nS to 2000 nS by connecting resistor between DT and ground. When DT pin left floating, fixed deadtime of 200 nS (Typical value) is inserted. The value of resistor can be calculated using following equation.

$$R_{DT}(k\Omega) = \frac{\text{Deadtime (nS)}}{5}$$

In device without DT pin (TSSOP package device), fixed deadtime of 200 nS (Typical value) is inserted to prevent high and low side gate output turning on at same time.

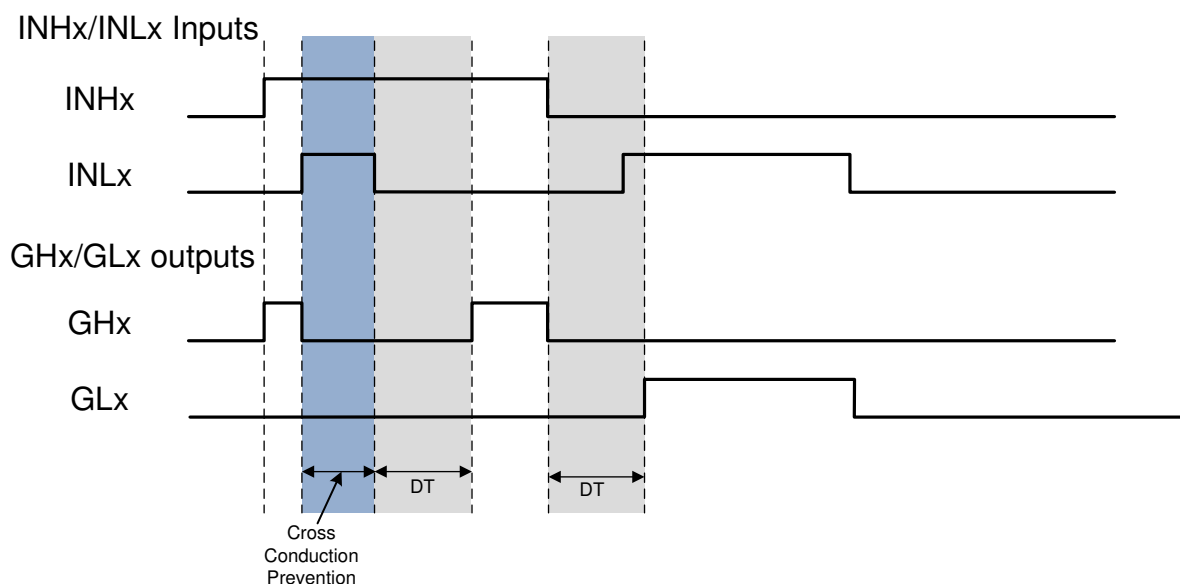


Figure 8-3. Cross Conduction Prevention and Deadtime Insertion

8.3.1.2 Mode (Inverting and non inverting INLx)

The DRV8300 has flexibility of accepting different kind of inputs on INLx. In devices with MODE pin (QFN package device), the DRV8300 provides option of GLx output inverted or non-inverted compared to polarity of signal on INLx pin. When MODE pin is left floating INLx is configured to be in non-inverting mode and GLx output is in phase with INLx (see [Figure 8-4](#)), whereas when MODE pin is connected to GVDD, GLx output is out of phase with inputs (see [Figure 8-5](#)). In devices without MODE pin (TSSOP package device), there are different device option available for inverting and non inverting inputs (see [Section 5](#))

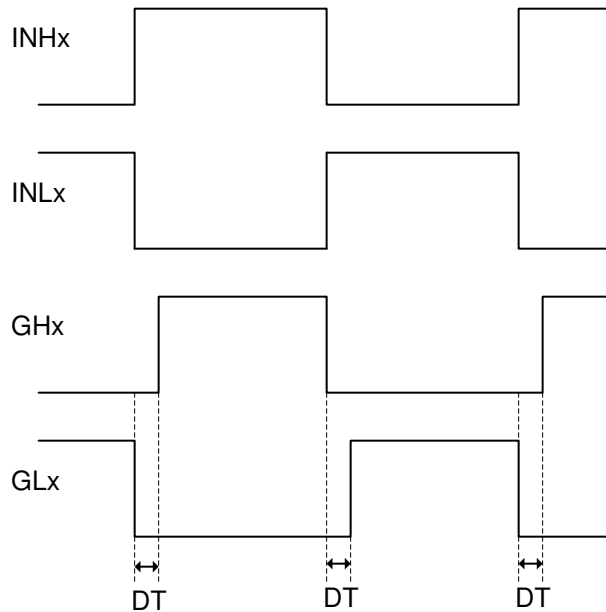


Figure 8-4. Non-Inverted INLx inputs

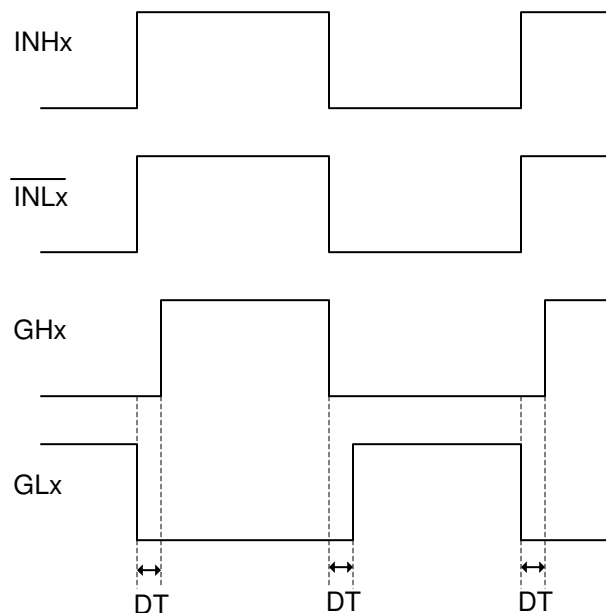
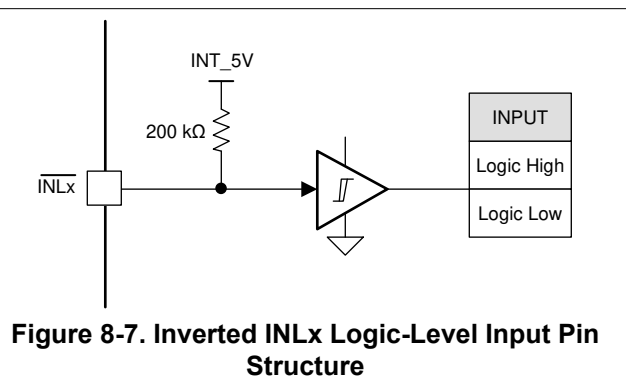
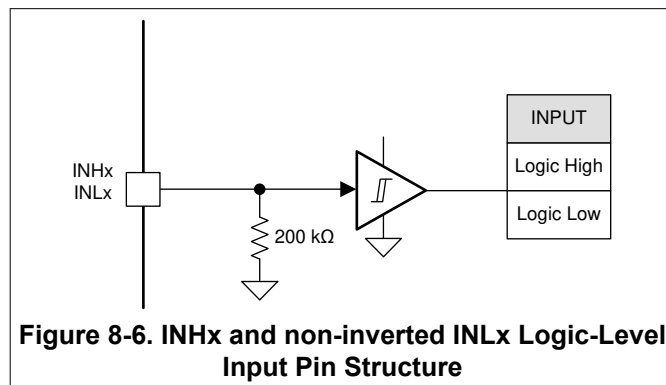


Figure 8-5. Inverted INLx inputs

8.3.2 Pin Diagrams

Figure 8-6 shows the input structure for the logic level pins INHx, INLx. INHx and INLx has passive pull down, so when inputs are floating the output of gate driver will be pulled low. Figure 8-7 shows the input structure for the logic level pin inverted INLx. INLx in inverted mode has passive pull up, so when inputs are floating the output of gate driver will be pulled low.



8.3.3 Gate Driver Protective Circuits

The DRV8300 is protected against BSTx undervoltage and GVDD undervoltage events.

Table 8-1. Fault Action and Response

| FAULT | CONDITION | GATE DRIVER | RECOVERY |
|---------------------------------|-------------------------|-------------|--|
| V_{BSTx} undervoltage (BSTUV) | $V_{BSTx} < V_{BSTUV}$ | GHx - Hi-Z | Automatic: $V_{BSTx} > V_{BSTUV}$ and low to high PWM edge detected on INHx pin |
| GVDD undervoltage (GVDDUV) | $V_{GVDD} < V_{GVDDUV}$ | Hi-Z | Automatic: $V_{GVDD} > V_{GVDDUV}$ |

8.3.3.1 V_{BSTx} Undervoltage Lockout (BSTUV)

The DRV8300 has separate voltage comparator to detect undervoltage condition for each phase. If at any time the supply voltage on the BSTx pin falls lower than the V_{BSTUV} threshold, high side external MOSFETs of that particular phase is disabled by disabling (Hi-Z) GHx pin. Normal operation starts again when the BSTUV condition clears and low to high PWM edge is detected on INHx input on the same phase BSTUV was detected. BSTUV protection ensures that high side gate driver are not switched when BSTx pin has lower value.

8.3.3.2 GVDD Undervoltage Lockout (GVDDUV)

If at any time the voltage on the GVDD pin falls lower than the V_{GVDDUV} threshold voltage, all of the external MOSFETs are disabled. Normal operation starts again GVDDUV condition clears. GVDDUV protection ensures that gate driver are not switched when GVDD input is at lower value.

8.4 Device Functional Modes

Whenever the $GVDD > V_{GVDDUV}$ and $V_{BSTx} > V_{BSTUV}$ the device is in operating (active) mode, in this condition gate driver output GHx and GLX will follow respective inputs INHx and INLx.

9 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

The DRV8300 family of devices is primarily used in applications for three-phase brushless DC motor control. The design procedures in the [Section 9.2](#) section highlight how to use and configure the DRV8300.

9.2 Typical Application

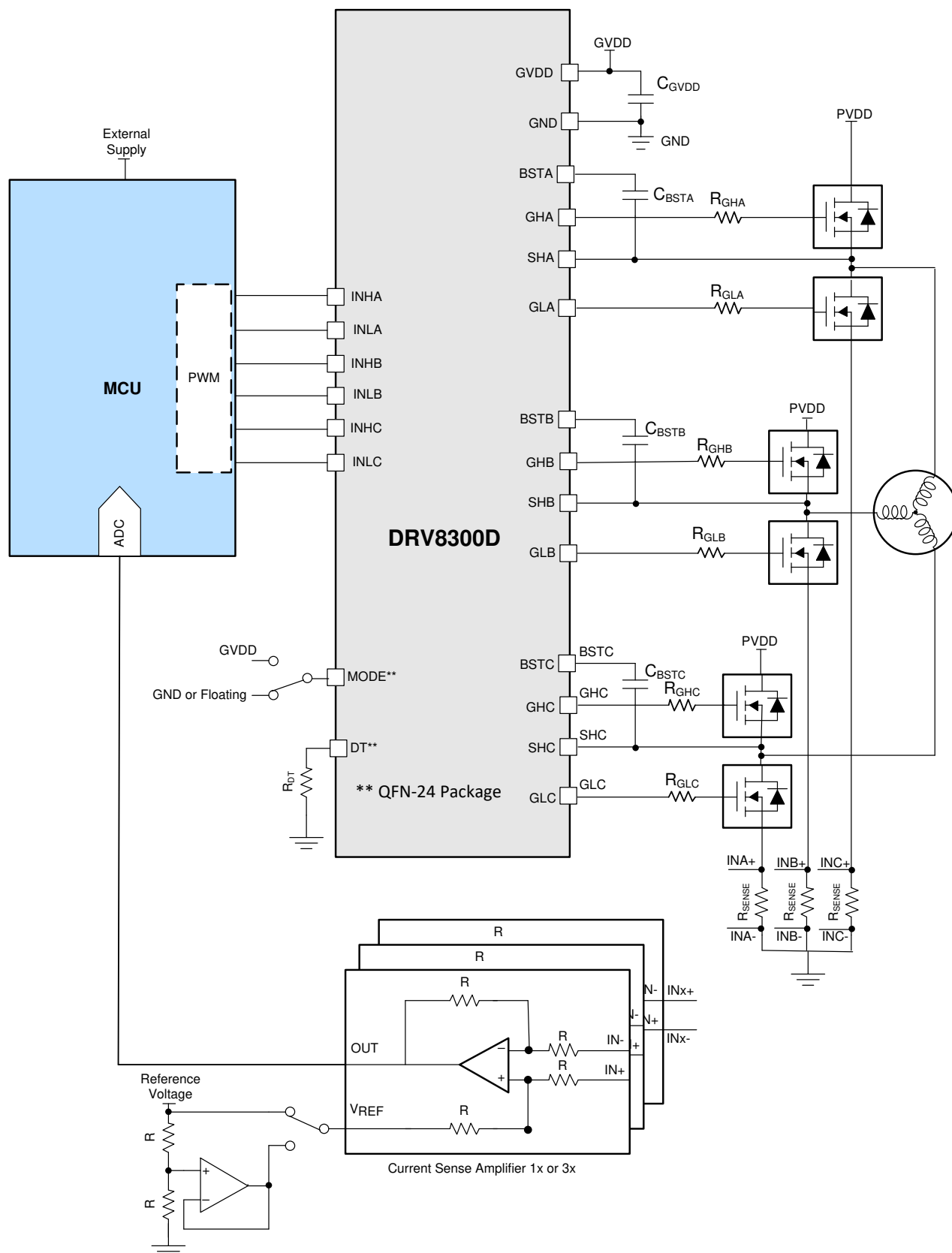


Figure 9-1. Application Schematic

9.2.1 Design Requirements

Table 9-1 lists the example design input parameters for system design.

Table 9-1. Design Parameters

| EXAMPLE DESIGN PARAMETER | REFERENCE | EXAMPLE VALUE |
|--------------------------|-------------------|---------------|
| MOSFET | - | CSD19532Q5B |
| Gate Supply Voltage | V _{GVDD} | 12 V |
| Gate Charge | Q _G | 48 nC |

9.2.2 Detailed Design Procedure

Bootstrap Capacitor and GVDD Capacitor Selection

The bootstrap capacitor must be sized to maintain the bootstrap voltage above the undervoltage lockout for normal operation. Equation 1 calculates the maximum allowable voltage drop across the bootstrap capacitor:

$$\Delta V_{BSTX} = V_{GVDD} - V_{BOOTD} - V_{BSTUV} \quad (1)$$

$$= 12 \text{ V} - 0.85 \text{ V} - 4.5 \text{ V} = 6.65 \text{ V}$$

where

- V_{GVDD} is the supply voltage of the gate drive
- V_{BOOTD} is the forward voltage drop of the bootstrap diode
- V_{BSTUV} is the threshold of the bootstrap undervoltage lockout

In this example the allowed voltage drop across bootstrap capacitor is 6.65 V. It is generally recommended that ripple voltage on both the bootstrap capacitor and GVDD capacitor should be minimized as much as possible. Many of commercial, industrial, and automotive applications use ripple value between 0.5 V to 1 V.

The total charge needed per switching cycle can be estimated with Equation 2:

$$Q_{TOT} = Q_G + \frac{I_{LBS_TRANS}}{f_{SW}} \quad (2)$$

$$= 48 \text{ nC} + 220 \text{ } \mu\text{A} / 20 \text{ kHz} = 50 \text{ nC} + 11 \text{ nC} = 59 \text{ nC}$$

where

- Q_G is the total MOSFET gate charge
- I_{LBS_TRAN} is the bootstrap pin leakage current
- f_{SW} is the is the PWM frequency

The minimum bootstrap capacitor an then be estimated as below assuming 1V ΔV_{BSTx}:

$$C_{BST_MIN} = Q_{TOT} / \Delta V_{BSTX} \quad (3)$$

$$= 59 \text{ nC} / 1 \text{ V} = 59 \text{ nF}$$

The calculated value of minimum bootstrap capacitor is 59 nF. It should be noted that, this value of capacitance is needed at full bias voltage. In practice, the value of the bootstrap capacitor must be greater than calculated value to allow for situations where the power stage may skip pulse due to various transient conditions. It is recommended to use a 100 nF bootstrap capacitor in this example. It is also recommended to include enough margin and place the bootstrap capacitor as close to the BSTx and SHx pins as possible.

Note

If device variants (DRV8300D) with integrated bootstrap diode are used with bootstrap capacitor value (C_{BSTX}) above 1 μF , then current flowing through internal bootstrap diode needs to be limited.

The local GVDD bypass capacitor must be greater than the value of bootstrap capacitor value (generally 10 times the bootstrap capacitor value).

$$C_{GVDD} \geq 10 \times C_{BSTX} \quad (4)$$

$$= 10 \times 100 \text{ nF} = 1 \mu\text{F}$$

For this example application choose 1 μF C_{GVDD} capacitor. Choose a capacitor with a voltage rating at least twice the maximum voltage that it will be exposed to because most ceramic capacitors lose significant capacitance when biased. This value also improves the long term reliability of the system.

Gate Resistance Selection

The slew rate of the SHx connection will be dependent on the rate at which the gate of the external MOSFETs is controlled. The pull-up/pull-down strength of the DRV8300 is fixed internally, hence slew rate of gate voltage can be controlled with an external series gate resistor. In some applications the gate charge, which is load on gate driver device, is significantly larger than gate driver peak output current capability. In such applications external gate resistors can limit the peak output current of the gate driver. External gate resistors are also used to damp ringing and noise.

The specific parameters of the MOSFET, system voltage, and board parasitics will all affect the final slew rate, so generally selecting an optimal value or configuration of external gate resistor is an iterative process.

9.2.3 Application Curves

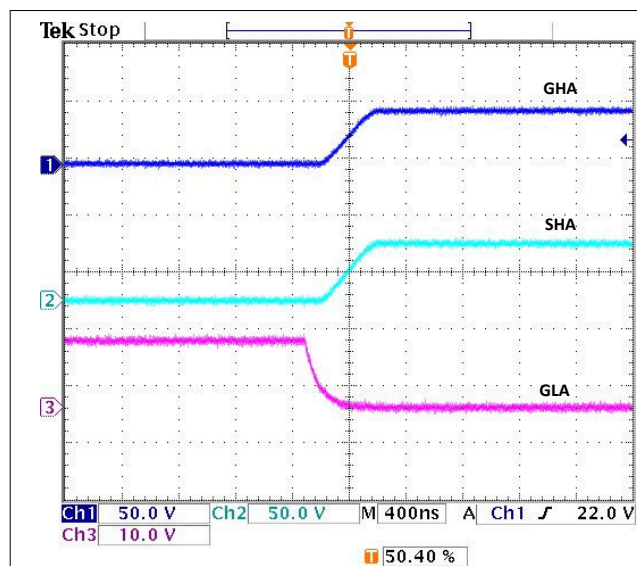


Figure 9-2. Gate voltages, SHx rising with 15 ohm gate resistor and CSD19532Q5B MOSFET

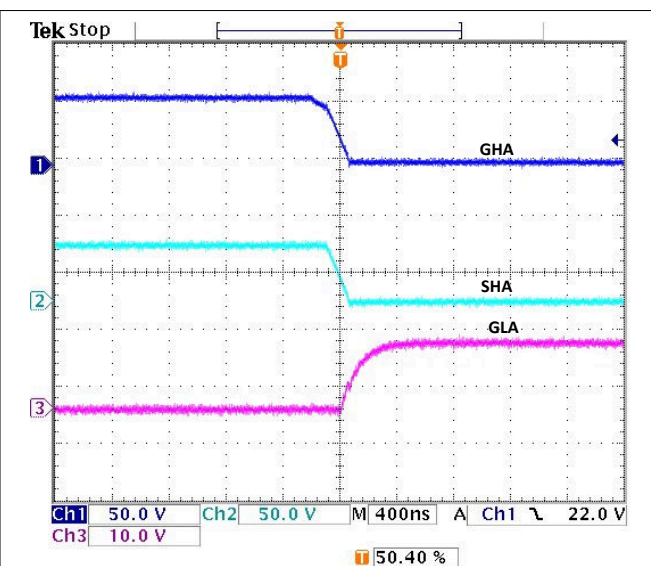


Figure 9-3. Gate voltages, SHx falling with 15 ohm gate resistor and CSD19532Q5B MOSFET

10 Power Supply Recommendations

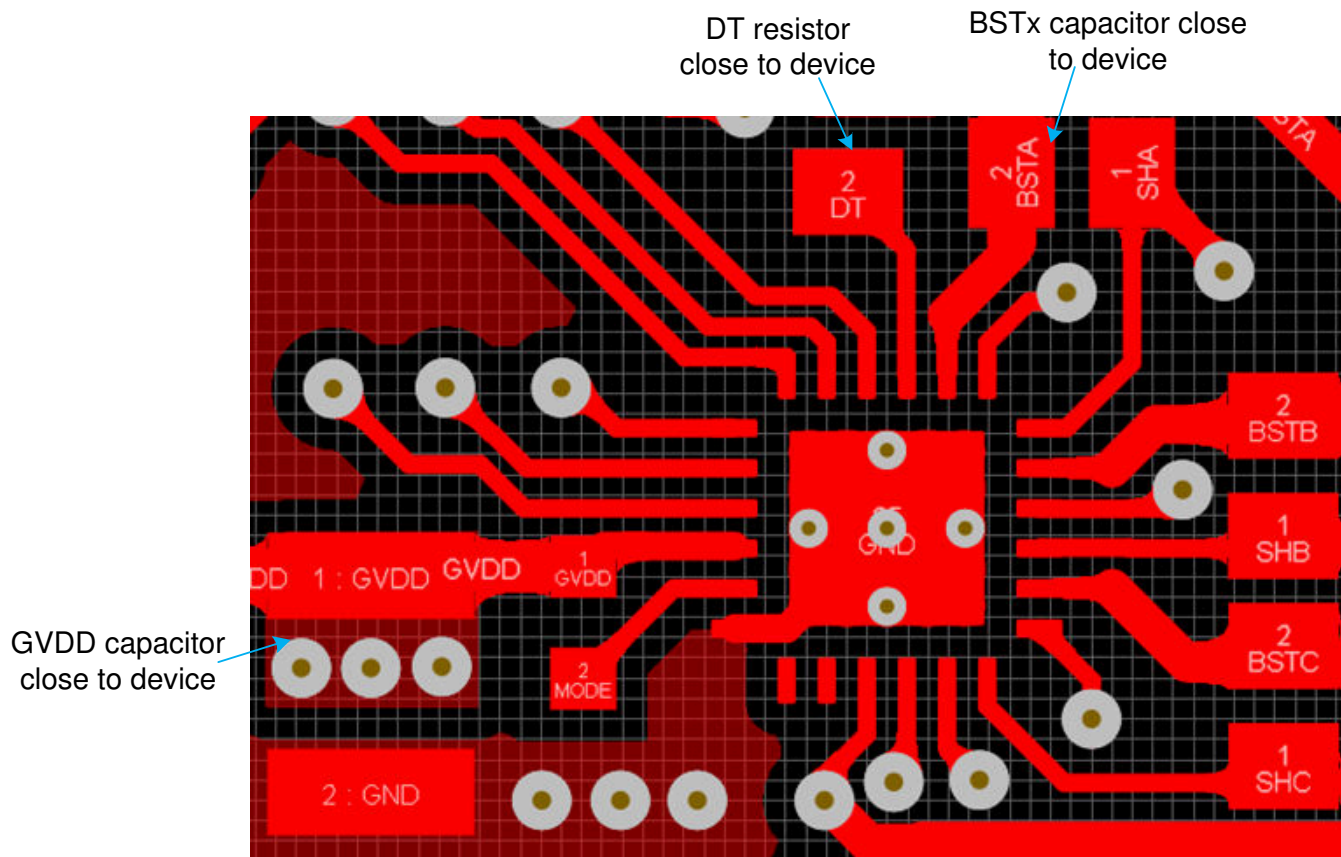
The DRV8300 is designed to operate from an input voltage supply (GVDD) range from 4.8 V to 20 V. A local bypass capacitor should be placed between the GVDD and GND pins. This capacitor should be located as close to the device as possible. A low ESR, ceramic surface mount capacitor is recommended. It is recommended to use two capacitors across GVDD and GND: a low capacitance ceramic surface-mount capacitor for high frequency filtering placed very close to GVDD and GND pin, and another high capacitance value surfacemount capacitor for device bias requirements. In a similar manner, the current pulses delivered by the GHx pins are sourced from the BSTx pins. Therefore, capacitor across the BSTx to SHx is recommended, it should be high enough capacitance value capacitor to deliver GHx pulses

11 Layout

11.1 Layout Guidelines

- Low ESR/ESL capacitors must be connected close to the device between GVDD and GND and between BSTx and SHx pins to support high peak currents drawn from GVDD and BSTx pins during the turn-on of the external MOSFETs.
- To prevent large voltage transients at the drain of the top MOSFET, a low ESR electrolytic capacitor and a good quality ceramic capacitor must be connected between the high side MOSFET drain and ground.
- In order to avoid large negative transients on the switch node (SHx) pin, the parasitic inductances between the source of the high-side MOSFET and the source of the low-side MOSFET must be minimized.
- In order to avoid unexpected transients, the parasitic inductance of the GHx, SHx, and GLx connections must be minimized. Minimize the trace length and number of vias wherever possible. Minimum 10 mil and typical 15 mil trace width is recommended.
- Resistance between DT and GND must be placed as close as possible to device
- Place the gate driver as close to the MOSFETs as possible. Confine the high peak currents that charge and discharge the MOSFET gates to a minimal physical area by reducing trace length. This confinement decreases the loop inductance and minimize noise issues on the gate terminals of the MOSFETs.
- In QFN package device variants, NC pins can be connected to GND to increase ground connection between thermal pad and external ground plane.
- Refer to sections *General Routing Techniques* and *MOSFET Placement and Power Stage Routing* in [Application Report](#)

11.2 Layout Example



12 Device and Documentation Support

12.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

12.2 Support Resources

[TI E2E™ support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

12.3 Trademarks

TI E2E™ is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

12.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

12.5 Glossary

[TI Glossary](#) This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

| Orderable Device | Status (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan (2) | Lead finish/ Ball material (6) | MSL Peak Temp (3) | Op Temp (°C) | Device Marking (4/5) | Samples |
|------------------|---------------|--------------|--------------------|------|----------------|-----------------|--------------------------------------|----------------------|--------------|-------------------------|-------------------------|
| DRV8300DIPWR | ACTIVE | TSSOP | PW | 20 | 3000 | RoHS & Green | NIPDAU | Level-2-260C-1 YEAR | -40 to 125 | 8300DI | Samples |
| DRV8300DPWR | ACTIVE | TSSOP | PW | 20 | 3000 | RoHS & Green | NIPDAU | Level-2-260C-1 YEAR | -40 to 125 | 8300D | Samples |
| DRV8300DRGER | ACTIVE | VQFN | RGE | 24 | 3000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 125 | 8300D | Samples |
| DRV8300NIPWR | ACTIVE | TSSOP | PW | 20 | 3000 | RoHS & Green | NIPDAU | Level-2-260C-1 YEAR | -40 to 125 | 8300NI | Samples |
| DRV8300NPWR | ACTIVE | TSSOP | PW | 20 | 3000 | RoHS & Green | NIPDAU | Level-2-260C-1 YEAR | -40 to 125 | 8300N | Samples |
| DRV8300NRGER | ACTIVE | VQFN | RGE | 24 | 3000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 125 | 8300N | Samples |

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

TAPE AND REEL INFORMATION



*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|--------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| DRV8300DIPWR | TSSOP | PW | 20 | 3000 | 330.0 | 16.4 | 6.95 | 7.1 | 1.6 | 8.0 | 16.0 | Q1 |
| DRV8300DPWR | TSSOP | PW | 20 | 3000 | 330.0 | 16.4 | 6.95 | 7.1 | 1.6 | 8.0 | 16.0 | Q1 |
| DRV8300DRGER | VQFN | RGE | 24 | 3000 | 330.0 | 12.4 | 4.25 | 4.25 | 1.15 | 8.0 | 12.0 | Q2 |
| DRV8300NIPWR | TSSOP | PW | 20 | 3000 | 330.0 | 16.4 | 6.95 | 7.1 | 1.6 | 8.0 | 16.0 | Q1 |
| DRV8300NPWR | TSSOP | PW | 20 | 3000 | 330.0 | 16.4 | 6.95 | 7.1 | 1.6 | 8.0 | 16.0 | Q1 |
| DRV8300NRGER | VQFN | RGE | 24 | 3000 | 330.0 | 12.4 | 4.25 | 4.25 | 1.15 | 8.0 | 12.0 | Q2 |

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|--------------|--------------|-----------------|------|------|-------------|------------|-------------|
| DRV8300DIPWR | TSSOP | PW | 20 | 3000 | 853.0 | 449.0 | 35.0 |
| DRV8300DPWR | TSSOP | PW | 20 | 3000 | 853.0 | 449.0 | 35.0 |
| DRV8300DRGER | VQFN | RGE | 24 | 3000 | 367.0 | 367.0 | 35.0 |
| DRV8300NIPWR | TSSOP | PW | 20 | 3000 | 853.0 | 449.0 | 35.0 |
| DRV8300NPWR | TSSOP | PW | 20 | 3000 | 853.0 | 449.0 | 35.0 |
| DRV8300NRGER | VQFN | RGE | 24 | 3000 | 367.0 | 367.0 | 35.0 |



TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.

EXAMPLE BOARD LAYOUT

PW0020A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X



4220206/A 02/2017

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

PW0020A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

4220206/A 02/2017

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

PW (R-PDSO-G20)

PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Publication IPC-7351 is recommended for alternate design.
 - D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
 - E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

RGE 24

GENERIC PACKAGE VIEW

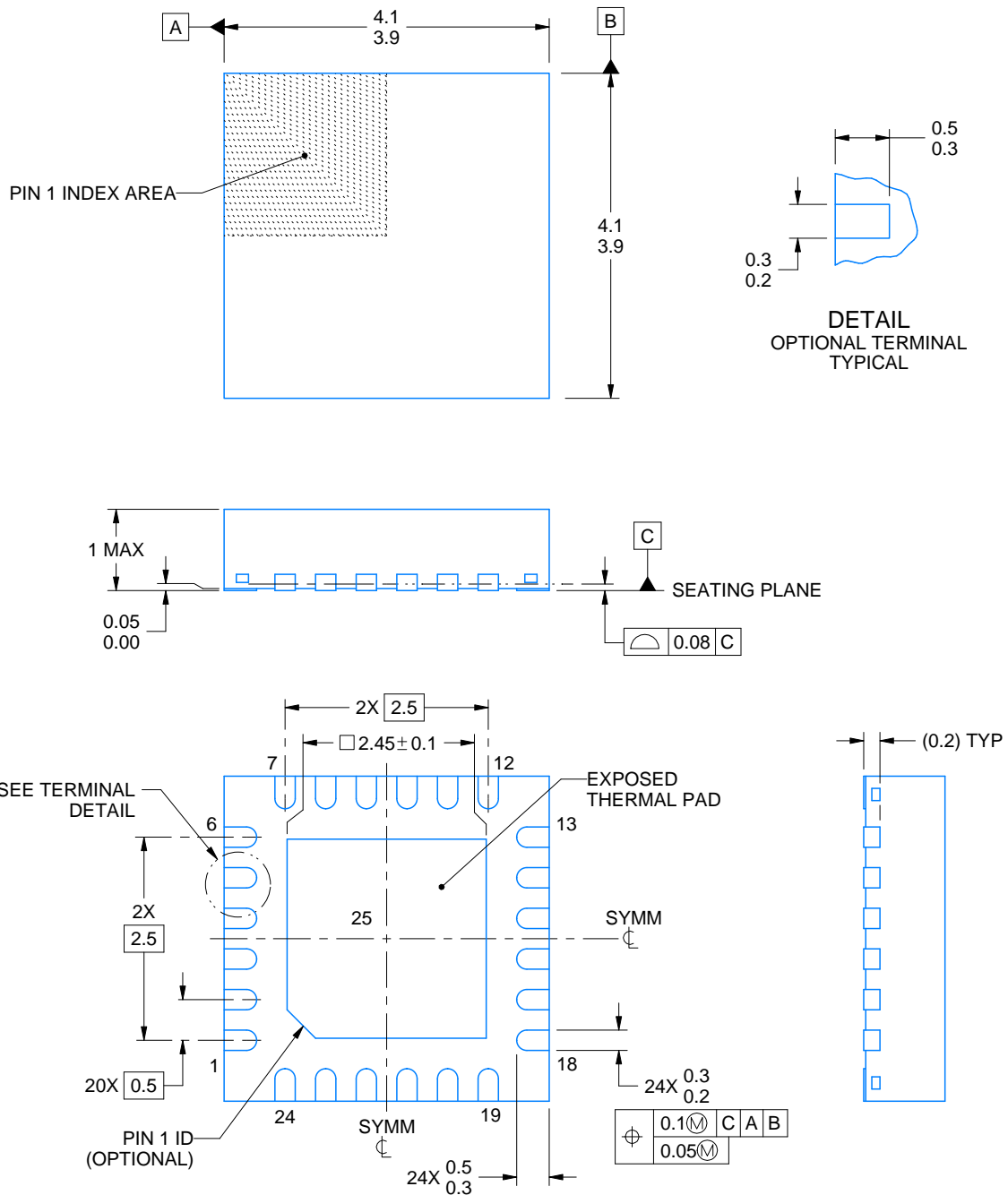
VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



Images above are just a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.

4204104/H



4219013/A 05/2017

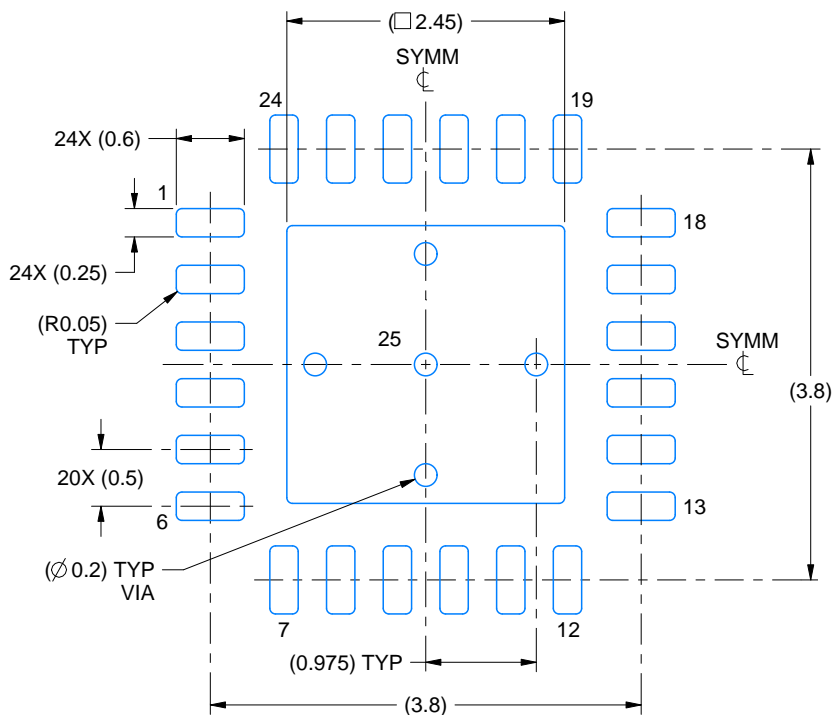
NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

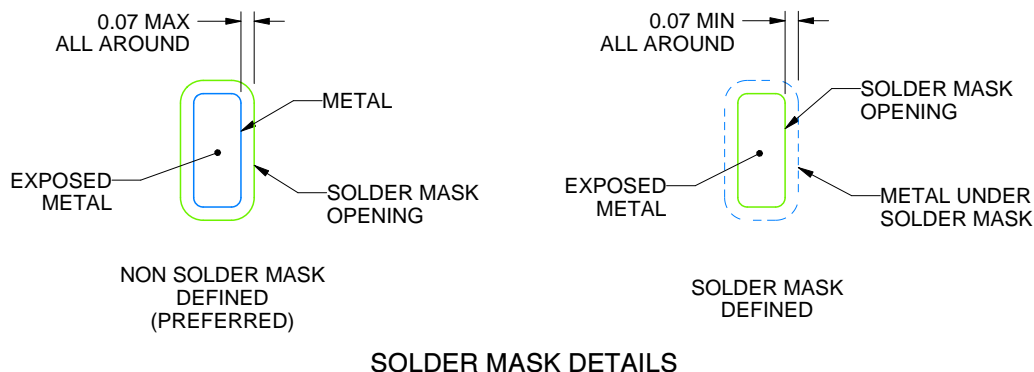
RGE0024B

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:15X



4219013/A 05/2017

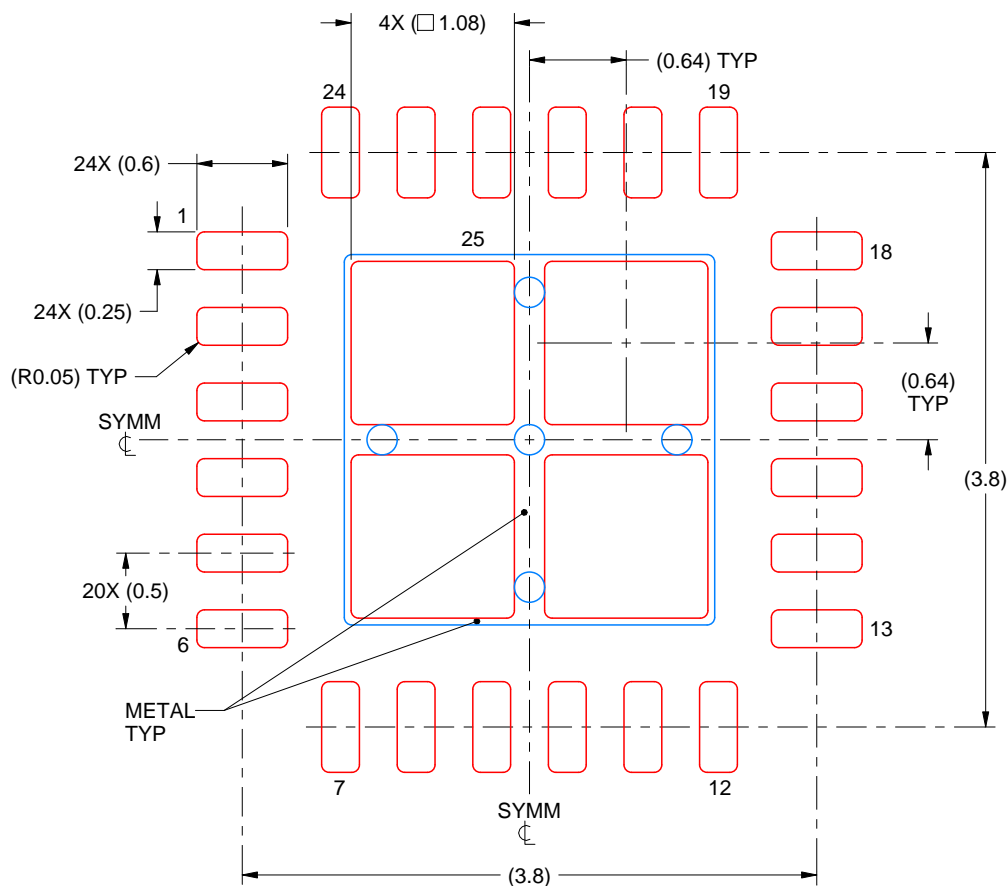
NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/sluea271).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

RGE0024B

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



SOLDER PASTE EXAMPLE BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD 25
78% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE
SCALE:20X

4219013/A 05/2017

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to [TI's Terms of Sale](#) or other applicable terms available either on [ti.com](#) or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265
Copyright © 2021, Texas Instruments Incorporated

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

[Texas Instruments:](#)

[DRV8300DPWR](#) [DRV8300DIPWR](#) [DRV8300NIPWR](#) [DRV8300NPWR](#) [DRV8300DRGER](#) [DRV8300NRGER](#)